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Application Number

First Named Inventor

Group Art Unit

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Filing Date

Substitute for form 1449A/PTO

THA 20

5665654

INFORMATION DISCLOSURE

STATEMENT BY APPLICANT

(use as many sheets as necessary)

Complese If Known

2841

J. Alcala

09/747,118

12/22/2000

Eldridge et al.

9/1997

Modified Form PTO/SB/08A

\sum_{i}	Sheet	1	of	2	Attorney Docket No.	P3D5-US					
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Lſ	2	U.S. PATENT DOCUMENTS									
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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ³Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁴Applicant is to place a check mark here if English language Translation is attached.

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				Application Number	09/747,118	
	RMATION			Filing Date	12/22/2000	
STATI	EMENT B	Y APPLIC	CANT	First Named Inventor	Eldridge et al.	
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Sheet	2	of	3	Attorney Docket No.	P3D5-US	
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	(_,,	Examiner Name	J. Alcala	
Sheet	3	of	3	Attorney Docket No.	P3D5-US	

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Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.). date, page(s), volume-issue number(s), publisher, city and/or country where published	T2						
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